Observation of Antiferromagnetic Domains in Epitaxial Thin Films


Antiferromagnetic domains in an epitaxial thin film, LaFeO$_3$ on SrTiO$_3$(100), were observed using a high-spatial-resolution photoelectron emission microscope with contrast generated by the large x-ray magnetic linear dichroism effect at the multiplet-split L edge of Fe. The antiferromagnetic domains are linked to 90° twinned crystallographic regions in the film. The Néel temperature of the thin film is reduced by 70 kelvin relative to the bulk material, and this reduction is attributed to epitaxial strain. These studies open the door for a microscopic understanding of the magnetic coupling across antiferromagnetic-ferromagnetic interfaces.

The current interest in magnetism is largely based on atomically engineered thin film structures, owing to the interesting physics of these materials and their technological use in the magnetic storage industry (1). An important and scientifically challenging class of materials is antiferromagnetic (AFM) thin films, which are extensively used in exchange bias applications (2). Exchange bias is used to magnetically pin a ferromagnetic layer to an adjacent antiferromagnet, thereby acting as a reference layer in a magnetic device. This technologically important effect is still poorly understood because of the inability of traditional techniques to spatially determine the microscopic magnetic structure of the AFM thin film. Although the AFM domain structure in bulk single crystals has been studied since the late 1950s (3, 4) little is known about the domain structure in thin films. For example, in well-annealed bulk NiO the typical domain size is in the range of 0.1 to 1 mm (3, 5), whereas in epitaxial NiO films the domain size has been estimated to be less than 50 nm (6). This size is below the spatial resolution of neutron diffraction topography (about 70 μm), x-ray diffraction topography (1 to 2 μm) (4), and the fundamental resolution limit (about 0.2 μm) set by diffraction for optical (3, 5) and nonlinear optical (7) techniques. Here we demonstrate the ability of x-ray spectromicroscopy to image the magnetic structure of AFM thin films with high spatial resolution, which is a necessary step toward a better understanding of exchange bias.

In particular, first images of the AFM domain structure in a thin film, LaFeO$_3$, grown epitaxially on SrTiO$_3$, are reported. They were obtained with x-ray magnetic linear dichroism (XMLD) spectromicroscopy (8, 9), using a new facility that combines a high-flux-density soft x-ray beam line with a high spatial resolution (20 nm) photoelectron emission microscope (PEEM) (10). Like PEEM spectromicroscopy of ferromagnets by use of circular dichroism (11), the XMLD-PEEM technique offers high spatial resolution in conjunction with elemental and chemical specificity and surface sensitivity (~2 nm sampling depth) (9).

The sample studied was a thin 40-nm LaFeO$_3$ film deposited on an asymmetric SrTiO$_3$(100) bicrystal, where two (100) crystals were joined macroscopically at (110) and (010) faces, leading to a 45° rotation of the lattice around the surface normal. The LaFeO$_3$ film was grown in an oxide molecular beam epitaxy (MBE) system by means of molecular beam epitaxy (MBE) system by means of a block-by-block growth method (12) at 750°C under a beam of atomic oxygen and a partial O$_2$ pressure of 5 × 10$^{-6}$ torr. This method has been shown to yield high-quality epitaxial films (13). The lattice parameters of bulk orthorhombic LaFeO$_3$ are a = 5.557 Å, b = 5.5652 Å, and c = 7.8542 Å (14), with the antiferromagnetic vector $\vec{A}$ pointing along the a axis (15). Plane-view electron diffraction and conventional transmission electron microscope (TEM) analysis of the epitaxial LaFeO$_3$ bicrystal, performed with a 200-kV JEOL 2010 microscope, showed that both macroscopic parts consist of four microscopic crystallographic domains characterized by orientations of the LaFeO$_3$ c axis along the [100], [-100], [010], and [001] directions in the SrTiO$_3$ surface plane. The a and b axes are canted by 45° out of the surface plane. A rectangular network of dislocations was observed, and their average distances were used to obtain the in-plane (pseudo-cubic) lattice parameters $a^*$ = 3.920 Å, $b^*$ = 3.938 Å, whereas the out-of-plane lattice parameter $c^*$ = 3.947 Å was obtained by means of x-ray diffraction.

The samples were studied with x-ray absorption spectroscopy and spectromicroscopy (10, 16). The focused, linearly polarized x-rays are incident on the sample at an angle of 30° from the surface, with the electric field vector $\vec{E}$ oriented parallel to the surface. The all-electrostatic PEEM microscope images low-energy secondary photoelectrons from the sample with magnification onto a phosphor screen that is read by a charge-coupled device (CCD) camera. The spatial resolution of PEEM2 is limited to 20 nm by chromatic aberrations. In order to avoid charging effects, the insulating LaFeO$_3$ sample was coated with a 1.5-nm Cu layer in the PEEM preparation chamber.

Our experiments make use of the large XMLD effect previously observed in α-Fe$_2$O$_3$ (17). In both α-Fe$_2$O$_3$ and LaFeO$_3$, the Fe$^{3+}$ ion has a 3d$^5$, high-spin (S = 5/2) ground state and an approximately octahedral environment. The L edge x-ray absorption fine structure for LaFeO$_3$ recorded by total electron yield detection (Fig. 1) is nearly identical to the experimental and theoretical spectra for α-Fe$_2$O$_3$ (17). For octahedral symmetry, there is no conventional linear (charge) dichroism, and the temperature and polarization dependence of the Fe L edge resonance intensity is given by (6, 18)

$$I(\theta, T) = a + b (3\cos^2 \theta - 1)(M^2)_T$$

(1)

where the first term is a constant and the second XMLD term depends on the x-ray polarization angle $\theta$ between $\vec{E}$ and the magnetic axis $\vec{A}$ and on temperature (T) through the magnetic moment ($M^2$)$_T$, which vanishes above the Néel temperature. Here we have neglected a smaller spin-spin correlation term.

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Fig. 1. Total electron yield of Fe L edge XMLD spectra for a 26-nm-thick film of LaFeO$_3$ grown on SrTiO$_3$(100). The spectra have been corrected for saturation effects and incomplete polarization alignment effects and correspond to alignment of the $\vec{E}$ vector along and perpendicular to the surface normal. a.u., arbitrary units.
The angle-dependent XMLD effect is due to a preferential orientation of the antiferromagnetic axis $\vec{A}$. In particular, peak A at 721.5 eV is larger than peak B at 723.2 eV (Fig. 1 inset) for $E \perp \vec{A}$ and smaller for $E \parallel \vec{A}$. From a careful study of the angular dependence of the XMLD effect in LaFeO$_3$ film on SrTiO$_3$ substrates with various symmetry (19), we determined that for LaFeO$_3$/SrTiO$_3$ (100), $\vec{A}$ is inclined 45° from the surface normal. The spectroscopy measurements do not reveal any preferential azimuthal orientation of $\vec{A}$ because they average over the fourfold symmetric domains.

The AFM domains can be directly observed by combining XMLD spectroscopy with PEEM microscopy; that is, by dividing a PEEM image acquired at 723.2 eV (peak B) by one obtained at 721.5 eV (peak A). The resultant image (Fig. 2) was recorded across the bicrystal junction (crystal orientation is indicated by arrows) and reveals striking AFM domains on the right side of the junction and a uniform gray shade on the left side. The strong magnetic contrast on the right side arises from magnetic domains with an in-plane projection of $\vec{A}$ parallel (white) and perpendicular (black) to the horizontal $E$ vector. On the left side, the domains cannot be distinguished because $E$ has an equal 45° projection onto the two orientations of $\vec{A}$. Because in our experimental geometry $E$ lies in the surface plane, we cannot distinguish domains whose axis $\vec{A}$ is rotated by 180° around the surface normal. Thus we only observed two of the four antiferromagnetic domains that have to exist by symmetry. A plan-view TEM image of the bicrystal is shown in the lower right inset of Fig. 2. The imaging conditions of this dark field image were chosen so that domains with orthogonal orientation of the $c$ axis gave rise to bright or dark contrast. The contrast is also affected by the presence of dislocations.

In a collection of XMLD images (Fig. 3) obtained at different temperatures between 290 and 550 K, the image contrast is strongly reduced at elevated temperatures and it is completely reversible upon cooling to room temperature, indicating that, within the studied temperature range, the magnetic state of the sample is not affected by chemical or diffusive processes at the sample surface. This is also supported by the unchanged x-ray absorption fine structure recorded before and after the temperature series. The quantitative XMLD image contrast is also plotted (Fig. 3), measured for two temperature cycles. According to Eq. 1, the XMLD contrast is a measure of the square of the AFM moment $(M^2)_p$. We have fitted the data in Fig. 3 with the shown solid line, using the exact expression for $(M^2)_p$ in terms of $(M_p)^2 (20, 21)$, which has been approximated following mean field theory with $S = 5/2 (21)$. Data and fit are normalized to 1 at 0 K. From the fit, we obtain the Néel temperature ($T_N$) = 670 ± 10 K for the thin film. This value is significantly reduced relative to that of bulk LaFeO$_3$, with $T_N$ = 740 K (Fig. 3, arrow (22)). The temperature dependence shown in Fig. 3 clearly establishes the AFM origin of the image contrast and indicates that crystallographic distortions of the octahedral Fe environment make only a negligible contribution.

The reduced Néel temperature is unlikely to be due to a finite size effect. Both the film thickness and the size of the crystallographic domains are considerably larger than the dimensions (about 10 nm) below which finite size effects have been found in AFM oxide films such as NiO and CoO (18, 23). Instead, we attribute the reduced Néel temperature to epitaxial strain. In mean field theory, the Néel temperature in LaFeO$_3$ is proportional to both the exchange constant $J$ and to the Fe spin $S$ according to $S (S + 1)$. Epitaxial strain affects $J$ through changes in the Fe-O-Fe superexchange angle (24), and it can reduce the high spin state $S = 5/2$ through crystal field effects associated with distortions of the FeO$_6$ octahedra. For our LaFeO$_3$ thin film, x-ray diffraction and TEM detect an in-plane lattice contraction along the $c$ axis of about 0.2% as compared to bulk LaFeO$_3$, with a comparable in-plane expansion perpendicular to $c$. The out-of-plane lattice expansion is even larger (0.4%). With two lattice parameters larger than the bulk values, the Fe-O-Fe bonding distance must increase, weakening the indirect exchange between Fe atoms and thus reducing the Néel temperature. Mismatch-induced strain has also been linked to a change of the critical temperature in cuprate superconductors (13).

PEEM spectromicroscopy is shown here to provide the necessary resolution and contrast to resolve the generally small (10 to 1000 nm) AFM domains in thin films. Our studies also open the door for combined linear and circular dichroism studies of the magnetic structure at ferromagnet-antiferromagnet interfaces (so-called exchange bias systems) that are both scientifically challenging and technologically important (2, 25).

Fig. 2. XMLD image obtained by division of images taken at photon energies 723.2 eV (peak B) and 721.5 eV (peak A) for the bicrystal sample. Arrows indicate the orientation of the crystallographic $c$ axes. Photon polarization $E$ is horizontal. The bottom left inset illustrates the relation between magnetic and crystallographic structure; the bottom right inset shows a plan-view TEM image of the bicrystal with image contrast arising from regions with orthogonal $c$ axes.

Fig. 3. Temperature dependence of the AFM domain contrast. A fit using $(M^2)_p$ mean field theory, resulting in $T_N$ = 670 K, is shown. The data and fit are normalized to 1 at 0 K.
Molecules in a Bose-Einstein Condensate
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State-selected rubidium-87 molecules were created at rest in a dilute Bose-Einstein condensate of rubidium-87 atoms with coherent free-bound stimulated Raman transitions. The transition rate exhibited a resonance line shape with an extremely narrow width as small as 1.5 kilohertz. The precise shape and position of the resonance are sensitive to the mean-field interactions between the molecules and the atomic condensate. As a result, we were able to measure the molecule-condensate interactions. This method allows molecular binding energies to be determined with unprecedented accuracy and is of interest as a mechanism for the generation of a molecular Bose-Einstein condensate.

The stimulated Raman process is illustrated in Fig. 1. The condensate is illuminated with two laser fields 1 and 2 of frequency \( \omega_1 \) and \( \omega_2 \), wavevectors \( \vec{k}_1 \) and \( \vec{k}_2 \), and intensity \( I_1 \) and \( I_2 \), respectively. A close pair of atoms from the condensate in a continuum state \( |f \rangle \) interacts through a potential \( V_R(R) \). This pair simultaneously absorbs a photon from laser field 1, emits a photon into laser field 2, and undergoes a transition to a molecular bound state \( |g \rangle \) of binding energy \( \epsilon \). The process becomes resonant when \( \Delta \omega = \omega_2 - \omega_1 = \epsilon \). This resonance condition is satisfied for only a single molecular ro-vibrational state, so only that state is formed. The momentum transferred from the photons to the molecule in the process is \( h(\vec{k}_1 - \vec{k}_2) \), and is almost exactly zero in our experiment, because the laser beams propagate in the same direction and have a very small frequency difference. Because the atoms in the condensate are almost perfectly at rest, the molecules are formed almost perfectly at rest inside the atomic condensate.

Our measurements were carried out in a Bose-condensed gas of \(^{87}\text{Rb} \) \(^{5}\text{S}_1\text{P}_1\), \( f = 1, m_f = -1 \) atoms confined in a magnetic trap. Here, \( f \) and \( m_f \) give the total spin and spin projection quantum numbers of the atoms. Our method to produce a condensate is similar to that first demonstrated by Anderson et al. (1), and has been described previously (14). The atoms were first captured in an optical trap in a high vacuum and were laser-cooled, then were transferred to a magnetic “TOP” trap (1) and further cooled with radio frequency–induced evaporation. The number of atoms, the gas temperature, and the fraction of the atoms in the condensate were measured with a laser-absorption imaging technique. For highly evaporated clouds, we could produce a gas with a temperature below 130 nK, condensate fraction greater than 80%, condensate atom number \( N_c = 3.6 \times 10^5 \), and peak condensate density \( n_1 = 2.7 \times 10^{14} \text{ cm}^{-3} \) in a harmonic trapping potential \( V(x,y) = (x^2 - y^2/2 + M^2/2x^2 + \omega(x^2 + y^2)/2, \) with \( \omega/2\pi = 54 \text{ Hz}, \omega/2\pi = 153 \text{ Hz}, \) and \( M \) the mass of an \(^{87}\text{Rb} \) atom. We also produced condensates with a smaller atom number and density by continuing the evaporation further and by adiabatically lowering the trapping frequencies.

After the production cycle, we illuminated the condensate with the two laser fields for a period \( \tau \) between 150 and 550 ms, with the trap left on. The TOP rotating magnetic field ampli-